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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/748,734	NAKAHARA, KEN	
Examiner	Art Unit	
Johannes P. Mondt	3663	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	ERFERENC	E SEARCHI	ED
Class	Subclass	Date	Examiner
	ncl PGPUB, ence printout.	1/2/2008	JPM

SEARCH NOT (INCLUDING SEARCH S	ES STRATEGY)
	DATE	EXMR
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